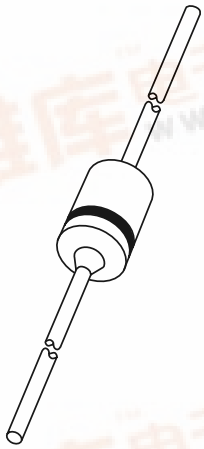
DATA SHEET



BYD33 series
Fast soft-recovery controlled avalanche rectifiers

Product specification
Supersedes data of 1996 Jun 05

1996 Sep 18

Philips Semiconductors

PHILIPS

Fast soft-recovery controlled avalanche rectifiers

BYD33 series

FEATURES

- Glass passivated
- High maximum operating temperature
- Low leakage current
- Excellent stability
- Guaranteed avalanche energy absorption capability
- Available in ammo-pack.

DESCRIPTION

Cavity free cylindrical glass package through Implotec™(1) technology. This package is hermetically sealed and fatigue free as coefficients of expansion of all used parts are matched.

(1) Implotec is a trademark of Philips.

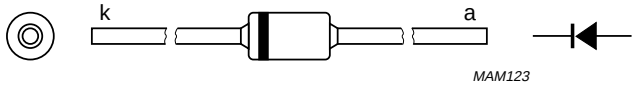


Fig.1 Simplified outline (SOD81) and symbol.

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V_{RRM}	repetitive peak reverse voltage				
	BYD33D		–	200	V
	BYD33G		–	400	V
	BYD33J		–	600	V
	BYD33K		–	800	V
	BYD33M		–	1000	V
	BYD33U		–	1200	V
	BYD33V		–	1400	V
V_R	continuous reverse voltage				
	BYD33D		–	200	V
	BYD33G		–	400	V
	BYD33J		–	600	V
	BYD33K		–	800	V
	BYD33M		–	1000	V
	BYD33U		–	1200	V
	BYD33V		–	1400	V
$I_{F(AV)}$	average forward current	T_{tp} = 55 °C; lead length = 10 mm; see Figs 2 and 3; averaged over any 20 ms period; see also Figs 10 and 11			
	BYD33D to M		–	1.30	A
	BYD33U and V		–	1.26	A
$I_{F(AV)}$	average forward current	T_{amb} = 65 °C; PCB mounting (see Fig.19); see Figs 4 and 5; averaged over any 20 ms period; see also Figs 10 and 11			
	BYD33D to M		–	0.70	A
	BYD33U and V		–	0.67	A
I_{FRM}	repetitive peak forward current	T_{tp} = 55 °C; see Figs 6 and 7			
	BYD33D to M		–	12	A
	BYD33U and V		–	11	A

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
I_{FRM}	repetitive peak forward current	T_{amb} = 65 °C; see Figs 8 and 9			
	BYD33D to M		–	7	A
	BYD33U and V		–	6	A
I_{FSM}	non-repetitive peak forward current	t = 10 ms half sine wave; $T_j = T_{j\,max}$ prior to surge; $V_R = V_{RRMmax}$	–	20	A
E_{RSM}	non-repetitive peak reverse avalanche energy	L = 120 mH; $T_j = T_{j\,max}$ prior to surge; inductive load switched off			
	BYD33D to J		–	10	mJ
	BYD33K to V		–	7	mJ
T_{stg}	storage temperature		–65	+175	°C
T_j	junction temperature	see Figs 12 and 13	–65	+175	°C

ELECTRICAL CHARACTERISTICS

T_j = 25 °C unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V_F	forward voltage	I_F = 1 A; $T_j = T_{j\,max}$; see Figs 14 and 15	–	–	1.1	V
		I_F = 1 A; see Figs 14 and 15	–	–	1.3	V
$V_{(BR)R}$	reverse avalanche breakdown voltage	I_R = 0.1 mA				
	BYD33D		300	–	–	V
	BYD33G		500	–	–	V
	BYD33J		700	–	–	V
	BYD33K		900	–	–	V
	BYD33M		1100	–	–	V
	BYD33U		1300	–	–	V
	BYD33V		1500	–	–	V
I_R	reverse current	$V_R = V_{RRMmax}$; see Fig.16	–	–	1	µA
		$V_R = V_{RRMmax}$; T_j = 165 °C; see Fig.16	–	–	100	µA
t_{rr}	reverse recovery time	when switched from I_F = 0.5 A to I_R = 1 A; measured at I_R = 0.25 A see Fig.21				
	BYD33D to J		–	–	250	ns
	BYD33K and M		–	–	300	ns
	BYD33U and V		–	–	500	ns
C_d	diode capacitance	f = 1 MHz; V_R = 0 V; see Figs 17 and 18	–	20	–	pF

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$\left\|\frac{dI_R}{dt}\right\|$	maximum slope of reverse recovery current	when switched from I_F = 1 A to $V_R \geq$ 30 V and dI_F/dt = –1 A/μs; see Fig.20				
	BYD33D to J		–	–	6	A/μs
	BYD33K to V		–	–	5	A/μs

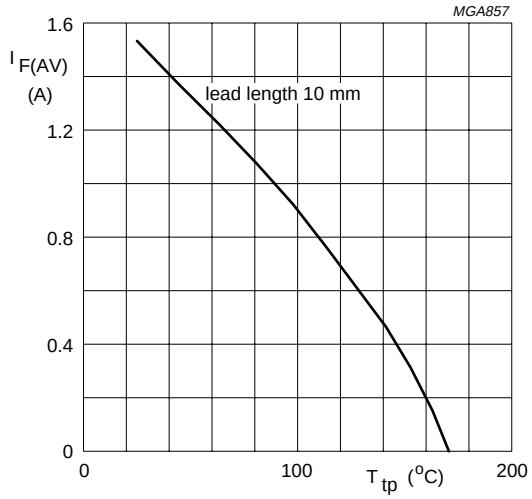
THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
$R_{th\ j\text{-}tp}$	thermal resistance from junction to tie-point	lead length = 10 mm	60	K/W
$R_{th\ j\text{-}a}$	thermal resistance from junction to ambient	note 1	120	K/W

Note

1. Device mounted on an epoxy-glass printed-circuit board, 1.5 mm thick; thickness of Cu-layer ≥40 μm, see Fig.19. For more information please refer to the *"General Part of associated Handbook"*.

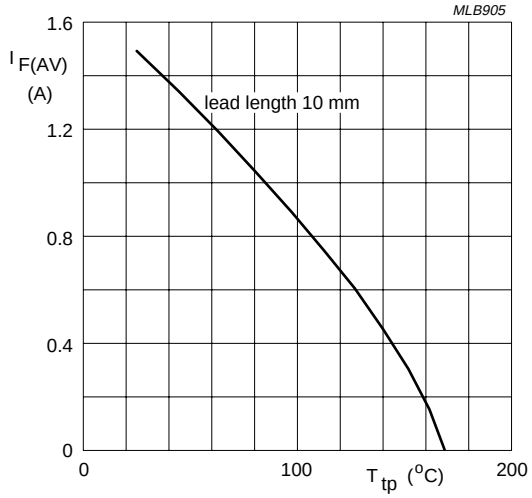
GRAPHICAL DATA



BYD33D to M

a = 1.42; $V_R = V_{RRMmax}$; δ = 0.5.
Switched mode application.

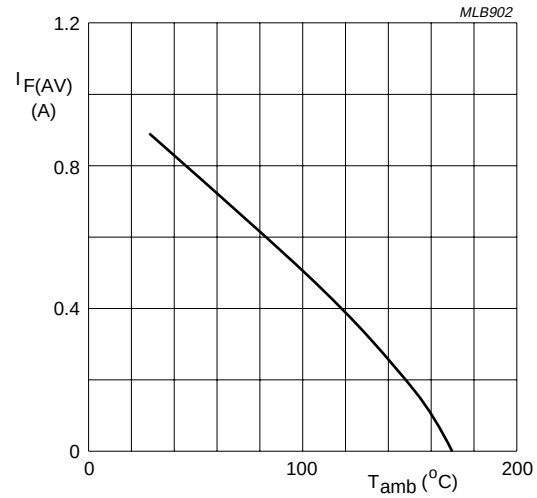
Fig.2 Maximum permissible average forward current as a function of tie-point temperature (including losses due to reverse leakage).



BYD33U and V

a = 1.42; $V_R = V_{RRMmax}$; δ = 0.5.
Switched mode application.

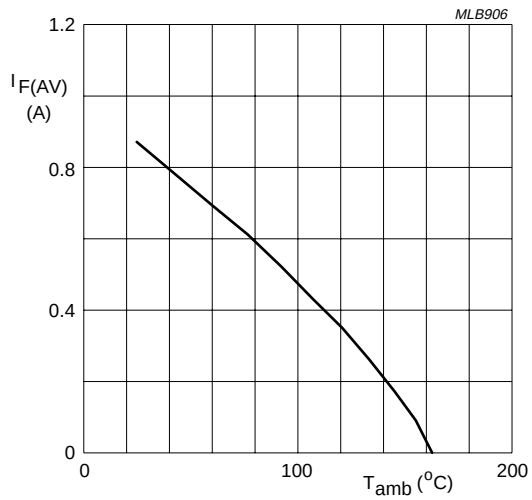
Fig.3 Maximum permissible average forward current as a function of tie-point temperature (including losses due to reverse leakage).



BYD33D to M

a = 1.42; $V_R = V_{RRMmax}$; δ = 0.5.
Device mounted as shown in Fig.19.
Switched mode application.

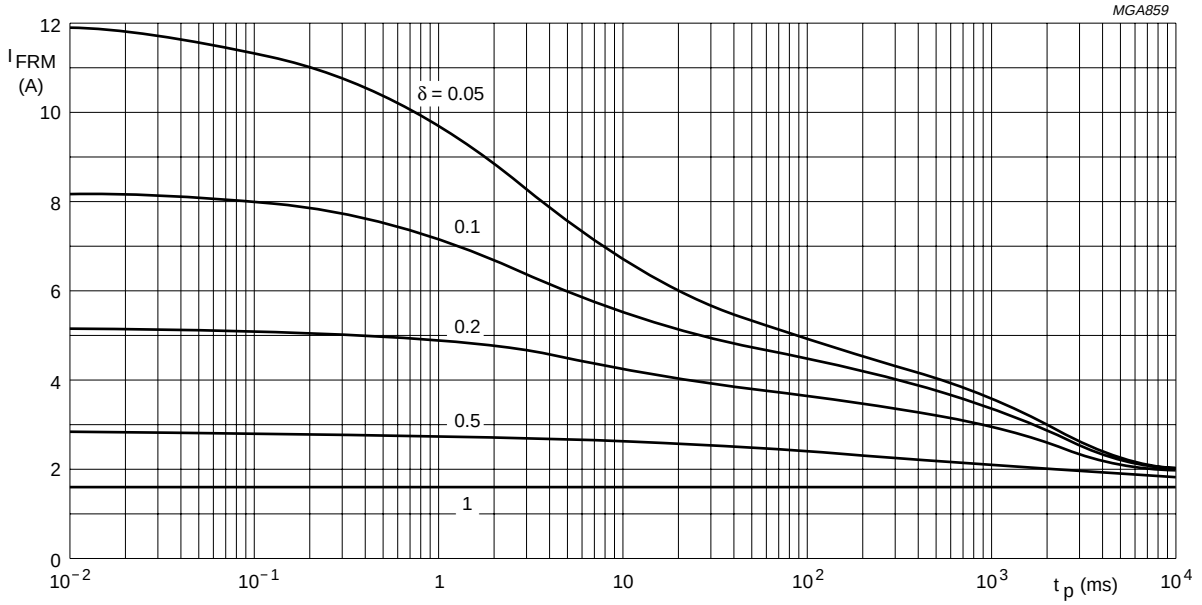
Fig.4 Maximum permissible average forward current as a function of ambient temperature (including losses due to reverse leakage).



BYD33U and V

a = 1.42; $V_R = V_{RRMmax}$; δ = 0.5.
Device mounted as shown in Fig.19.
Switched mode application.

Fig.5 Maximum permissible average forward current as a function of ambient temperature (including losses due to reverse leakage).

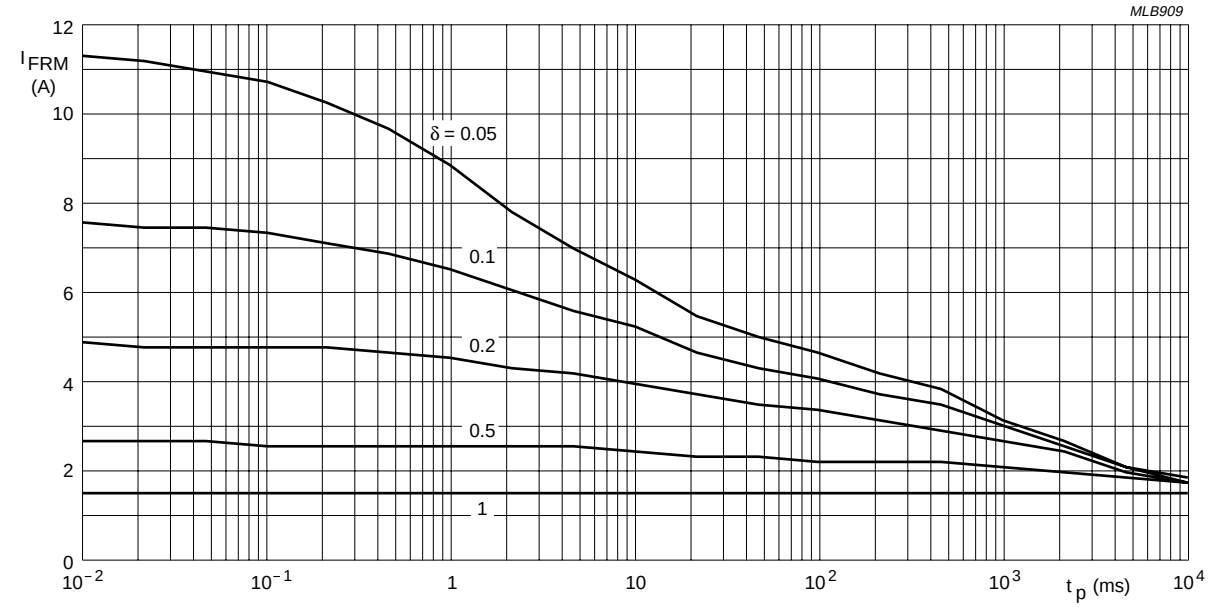


BYD33D to M

T_{tp} = 55 °C; $R_{th\ j\text{-}tp}$ = 60 K/W.

V_{RRMmax} during 1 – δ; curves include derating for $T_{j\ max}$ at V_{RRM} = 1000 V.

Fig.6 Maximum repetitive peak forward current as a function of pulse time (square pulse) and duty factor.

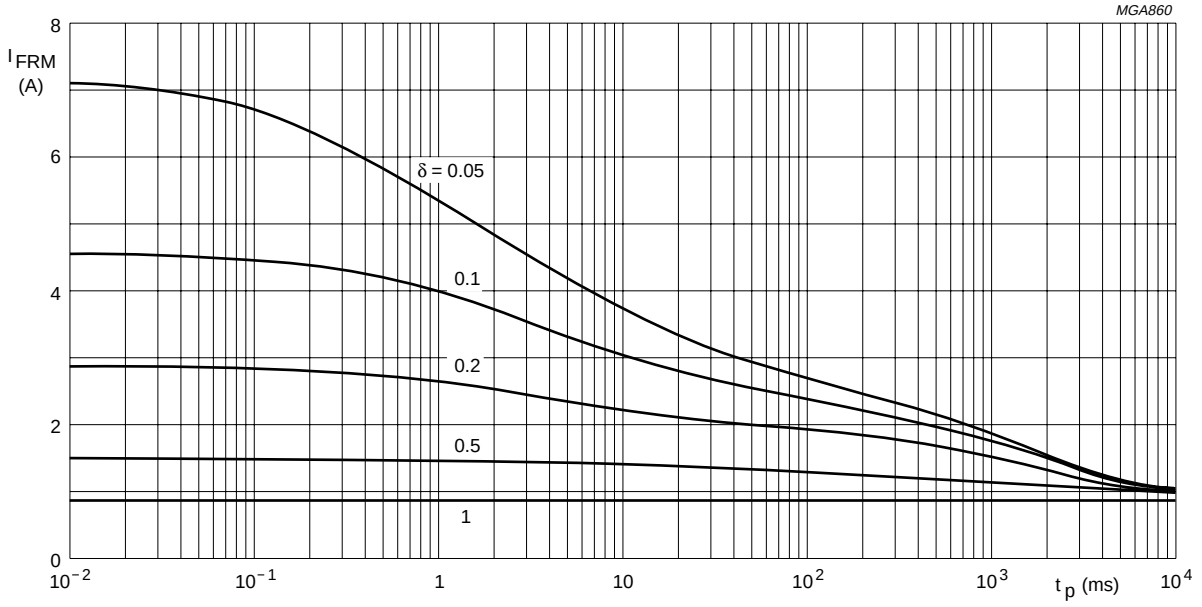


BYD33U and V

T_{tp} = 55°C; $R_{th\ j\text{-}tp}$ = 60 K/W.

V_{RRMmax} during 1 – δ; curves include derating for $T_{j\ max}$ at V_{RRM} = 1400 V.

Fig.7 Maximum repetitive peak forward current as a function of pulse time (square pulse) and duty factor.

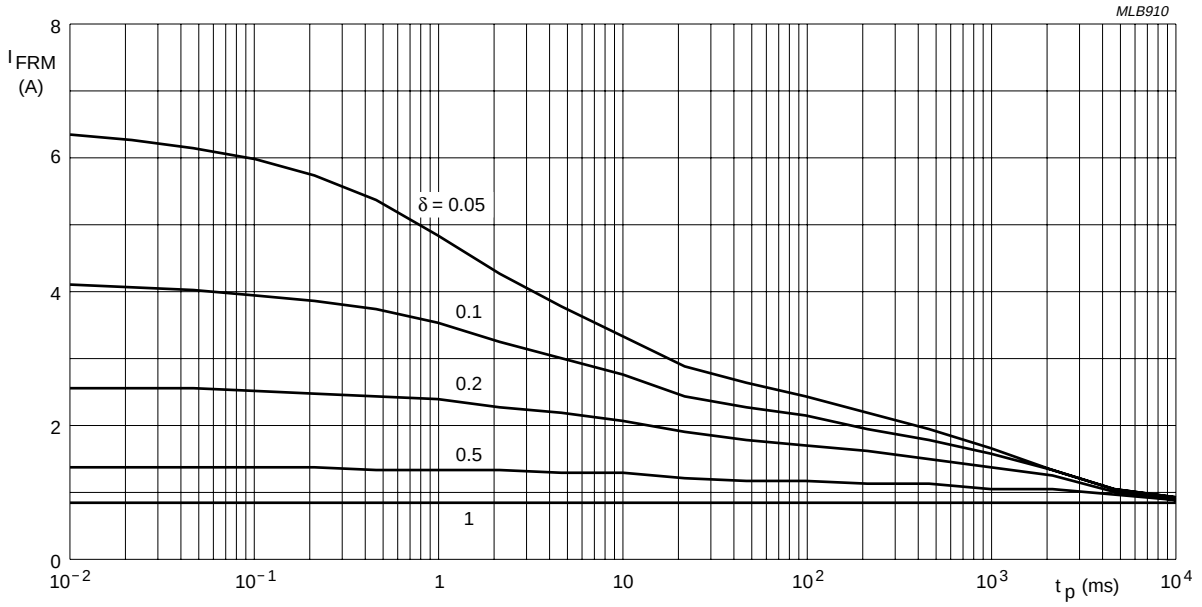


BYD33D to M

T_{amb} = 65 °C; $R_{th\ j\text{-}a}$ = 120 K/W.

V_{RRMmax} during 1 – δ; curves include derating for $T_{j\ max}$ at V_{RRM} = 1000 V.

Fig.8 Maximum repetitive peak forward current as a function of pulse time (square pulse) and duty factor.

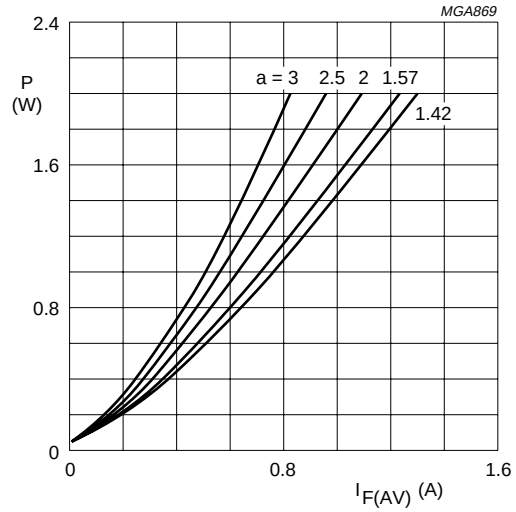


BYD33U and V

T_{amb} = 65 °C; $R_{th\ j\text{-}a}$ = 120 K/W.

V_{RRMmax} during 1 – δ; curves include derating for $T_{j\ max}$ at V_{RRM} = 1400 V.

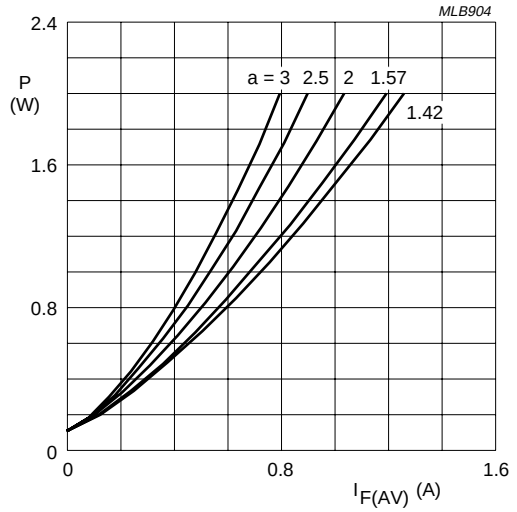
Fig.9 Maximum repetitive peak forward current as a function of pulse time (square pulse) and duty factor.



BYD33D to M

$a = I_{F(RMS)}/I_{F(AV)}$; $V_R = V_{RRMmax}$; $\delta = 0.5$.

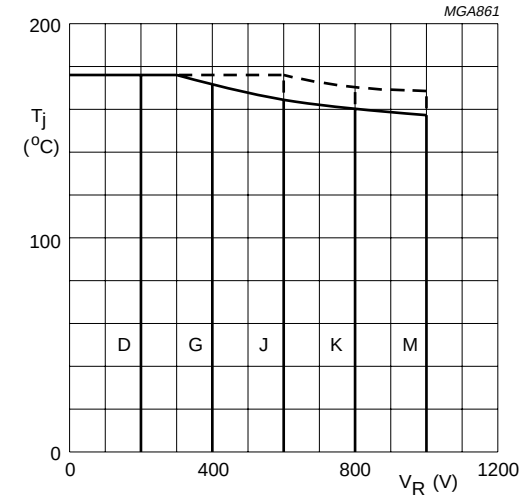
Fig.10 Maximum steady state power dissipation (forward plus leakage current losses, excluding switching losses) as a function of average forward current.



BYD33U and V

$a = I_{F(RMS)}/I_{F(AV)}$; $V_R = V_{RRMmax}$; $\delta = 0.5$.

Fig.11 Maximum steady state power dissipation (forward plus leakage current losses, excluding switching losses) as a function of average forward current.

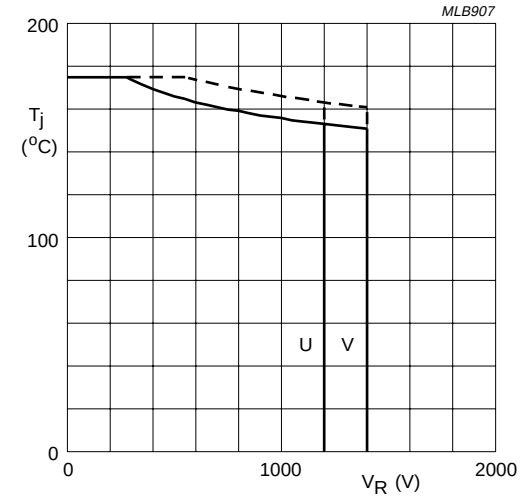


BYD33D to M

Solid line = V_R.

Dotted line = V_{RRM}; $\delta = 0.5$.

Fig.12 Maximum permissible junction temperature as a function of reverse voltage.

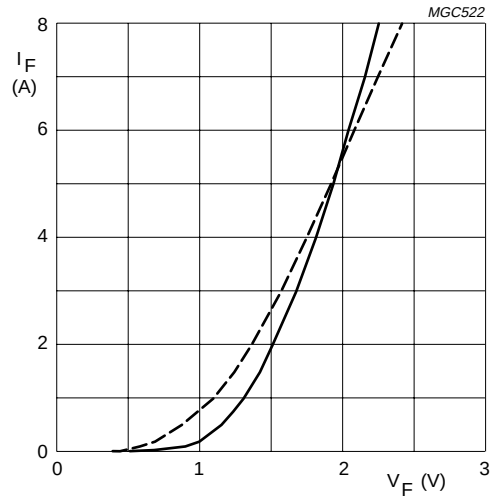


BYD33U and V

Solid line = V_R.

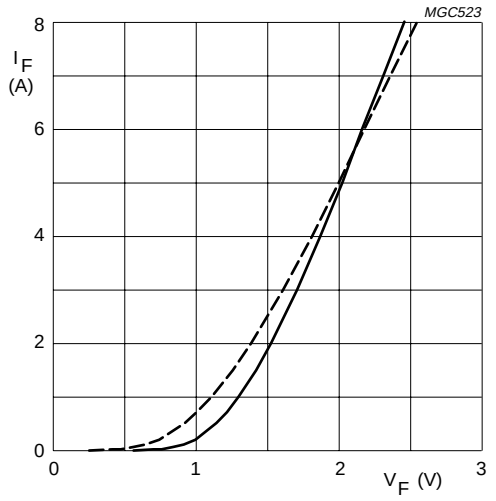
Dotted line = V_{RRM}; $\delta = 0.5$.

Fig.13 Maximum permissible junction temperature as a function of reverse voltage.



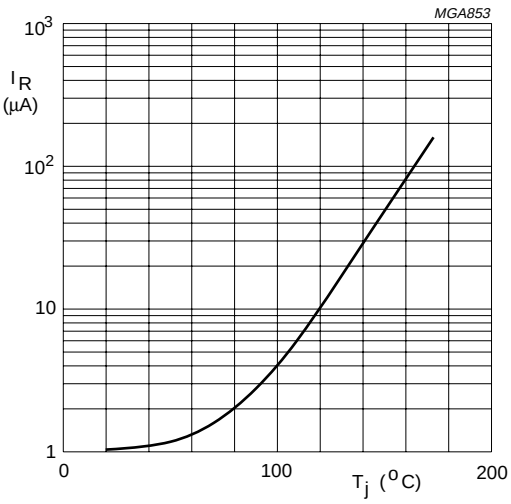
BYD33D to M
Solid line: T_j = 25 °C.
Dotted line: T_j = 175 °C.

Fig.14 Forward current as a function of forward voltage; maximum values.



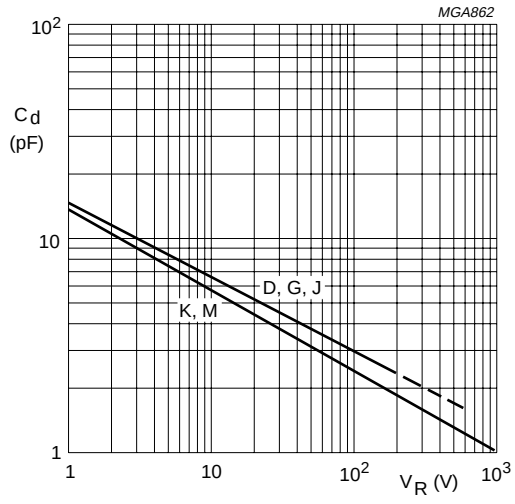
BYD33U and V
Solid line: T_j = 25 °C.
Dotted line: T_j = 175 °C.

Fig.15 Forward current as a function of forward voltage; maximum values.



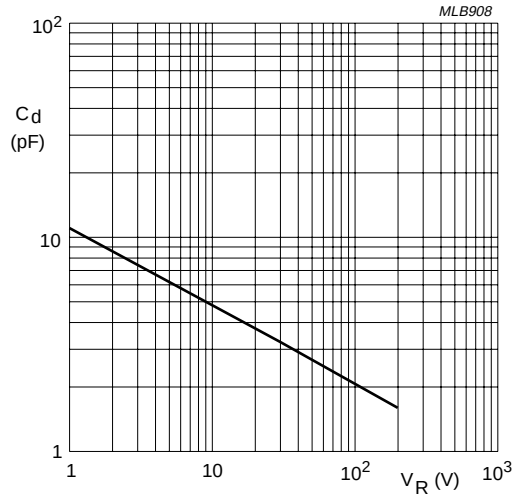
$V_R = V_{RRMmax}$.

Fig.16 Reverse current as a function of junction temperature; maximum values.



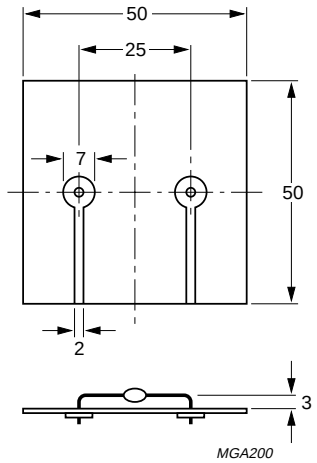
BYD33D to M
f = 1 MHz; T_j = 25 °C.

Fig.17 Diode capacitance as a function of reverse voltage; typical values.



BYD33U and V
f = 1 MHz; T_j = 25 °C.

Fig.18 Diode capacitance as a function of reverse voltage; typical values.



Dimensions in mm.

Fig.19 Device mounted on a printed-circuit board.

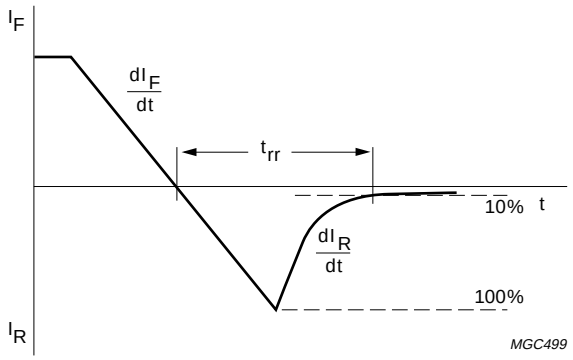
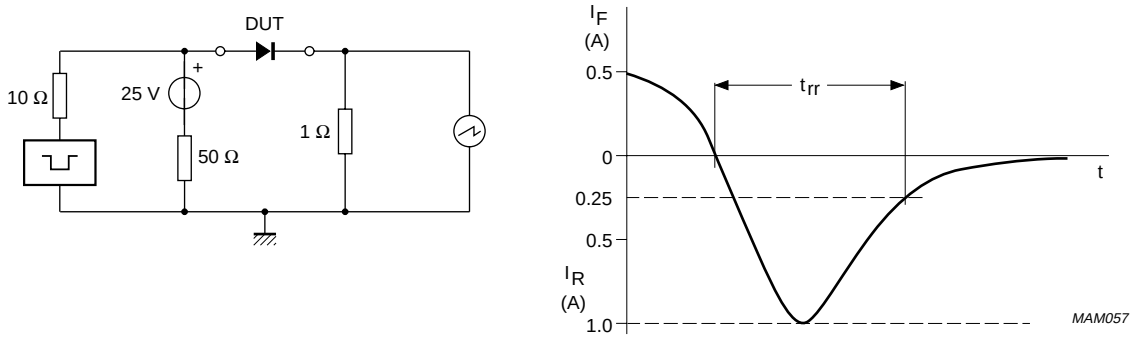


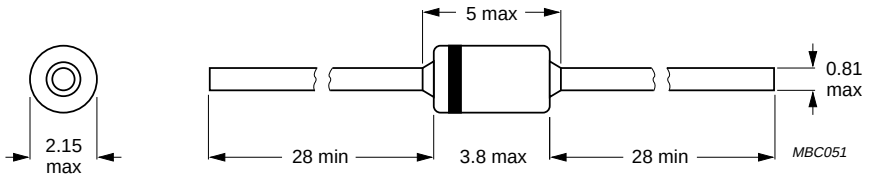
Fig.20 Reverse recovery definitions.



Input impedance oscilloscope: 1 MΩ, 22 pF; $t_r \leq 7$ ns.
Source impedance: 50 Ω; $t_r \leq 15$ ns.

Fig.21 Test circuit and reverse recovery time waveform and definition.

PACKAGE OUTLINE



Dimensions in mm.
The marking band indicates the cathode.

Fig.22 SOD81.

DEFINITIONS

Data Sheet Status	
Objective specification	This data sheet contains target or goal specifications for product development.
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.
Product specification	This data sheet contains final product specifications.
Limiting values	
Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.	
Application information	
Where application information is given, it is advisory and does not form part of the specification.	

LIFE SUPPORT APPLICATIONS

These products are not designed for use in life support appliances, devices, or systems where malfunction of these products can reasonably be expected to result in personal injury. Philips customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify Philips for any damages resulting from such improper use or sale.